

**LISTE DES PARTICIPANTS/
LIST OF PARTICIPANTS/
LISTA DE PARTICIPANTES**

I. ÉTATS MEMBRES/MEMBER STATES

(dans l'ordre alphabétique des noms français des États/
in alphabetical order of the names in French of the States)

ALLEMAGNE/GERMANY

Klaus HOEFKEN, Head, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

AUTRICHE/AUSTRIA

Burkhard SCHLECHTER, Head of Classification, Technical Department 3A, The Austrian Patent Office, Federal Ministry for Transport, Innovation and Technology, Vienna

BRÉSIL/BRAZIL

Catia VALDMAN (Ms.), Patent Examiner, Telecommunications Division, National Institute of Industrial Property (INPI), Ministry of Development, Industry and Foreign Trade, Rio de Janeiro

CANADA

Nancy BEAUCHEMIN (Mme), gestionnaire de programme-international, Direction des brevets, Office de la propriété intellectuelle du Canada (CIPO), Gatineau

CHINE/CHINA

LU Huisheng, Director, International Communication Division, Patent Documentation Department, State Intellectual Property Office of the People's Republic of China, Beijing

YANG Jia, Deputy Section Director, Patent Examination Cooperation Center of the Patent Office, State Intellectual Property Office of the People's Republic of China, Beijing

REN Jie, Classification Quality Controller, State Intellectual Property Office of the People's Republic of China, Beijing

DANEMARK/DENMARK

Sven Nytoft RASMUSSEN, Senior Examiner, Patent Department, Ministry of Business and Growth, Danish Patent and Trademark Office, Taastrup

ESPAGNE/SPAIN

Amaya EZCURRA MARTÍNEZ (Sra.), Jefe, Servicio Técnicas Industriales, Departamento de Patentes e Información Tecnológica, Oficina Española de Patentes y Marcas (OEPM), Ministerio de Industria, Energía y Turismo, Madrid

ESTONIE/ESTONIA

Tiina LILLEPOOL (Ms.), Deputy Head, Patent Department, Estonian Intellectual Property and Technology Transfer Centre, Tallinn

ÉTATS-UNIS D'AMÉRIQUE/UNITED STATES OF AMERICA

Christopher KIM, Director, Classification Quality and International Coordination, Office of International Patent Cooperation, United States Department of Commerce, United States Patent and Trademark Office (USPTO), Alexandria

Matthew SMITH, Classification Standards and Development, United States Department of Commerce, United States Patent and Trademark Office (USPTO), Alexandria

Richard LEE, Patent Classifier (International Projects), United States Department of Commerce, United States Patent and Trademark Office (USPTO), Alexandria

FÉDÉRATION DE RUSSIE/RUSSIAN FEDERATION

Zoya VOYTSEKHOVSKAYA (Ms.), Senior Researcher, International Patent Classification Division, FIPS of Rospatent, Moscow

FINLANDE/FINLAND

Niko MUSAKKA, Patent Examiner, Chemistry Department, Finnish Patent and Registration Office (PRH), Ministry of Employment and the Economy, Helsinki

FRANCE

Céline MAGOU SANTIANO (Mme), chargée de mission CIB, Département des brevets, Institut national de la propriété industrielle (INPI), Paris

IRLANDE/IRELAND

Karen RYAN (Ms.), Patent Examiner, Patents Office, Department of Jobs, Enterprise and Innovation, Kilkenny

ITALY

Francesca MARIANO NARNI (Ms.), Intern, Permanent Mission, Geneva

JAPON/JAPAN

Kunihiko FUSHIMI, Director, Policy Planning and Research, Administrative Affairs Division, Japan Patent Office, Tokyo

Masakazu SHIOZAWA, Deputy Director, Administrative Affairs Division, Japan Patent Office, Tokyo

Tatsuya OHASHI, Assistant Director, Administrative Affairs Division, Japan Patent Office, Tokyo

MEXIQUE/MEXICO

Pablo ZENTENO MÁRQUEZ, Especialista en Propiedad Industrial A, Dirección Divicional de Patentes, Instituto Mexicano de la Propiedad Industrial (IMPI), Mexico

NORVÈGE/NORWAY

Natalie SCHLAF (Ms.), Chief Examiner, Chemistry, Norwegian Industrial Property Office (NIPO), Oslo

PAYS-BAS/NETHERLANDS

Robert SCHOUWENAARS, Patent Examiner, Netherlands Patent Office: a Department of the Netherlands Enterprise Agency, Ministry of Economic Affairs, The Hague

PORTUGAL

Vanessa FATAL (Ms.), Patent Examiner, Patents and Utility Models Department, Ministry of Justice, Portuguese Institute of Industrial Property, Lisbon

RÉPUBLIQUE DE CORÉE/REPUBLIC OF KOREA

LEE Yong-Sang, Assistant Manager, IPC Revision, Patent Information Promotion Center (PIPC), Daejeon

KWON Min Jeong (Ms.), Deputy Director, Measurement and Analysis Technology Examination Division, Korean Intellectual Property Office (KIPO), Daejeon

LEE Eunkyū, Deputy Director, Patent Examination Policy Division, Korean Intellectual Property Office (KIPO), Daejeon

RÉPUBLIQUE TCHÈQUE/CZECH REPUBLIC

Jarmila AVRATOVÁ (Ms.), Engineer, Patent Information Department, Industrial Property Office, Prague

ROUMANIE/ROMANIA

Diana NITA (Ms.), Patent Examiner, Patent Directorate, State Office for Inventions and Trademarks (OSIM), Bucharest

Simona RADU (Ms.), Patent Examiner, Patent Directorate, State Office for Inventions and Trademarks (OSIM), Bucharest

ROYAUME-UNI/UNITED KINGDOM

Peter SLATER, Deputy Director, Patents, UK Intellectual Property Office Newport

Jeremy COWEN, Senior Patent Examiner, Classification, Department for Business, Innovation and Skills, UK Intellectual Property Office, Newport

SLOVAQUIE/SLOVAKIA

Zuzana HANČULÁKOVÁ (Ms.), Standards and Documentation Expert, IT Operations, Industrial Property Office of the Slovak Republic, Banská Bystrica

SUÈDE/SWEDEN

Anders BRUUN, Patent Expert, Swedish Patent and Registration Office, Stockholm

SUISSE/SWITZERLAND

Pascal WEIBEL, chef Examen, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

TURQUIE/TURKEY

Atalay Berk DAMGACIOGLU, Patent Examiner, Patent Department, Turkish Patent Institute, Ankara

UKRAINE

Andrew KUDIN, Director General, State Enterprise "Ukrainian Intellectual Property Institute", Kyiv
Sergii TORIANIK, Deputy Head, Division of Examination of Applications for Inventions, Utility Models and Topographies of Integrated Circuits, State Enterprise, Kyiv

II. ORGANISATIONS INTERGOUVERNEMENTALES/INTERGOVERNMENTAL ORGANIZATIONS

ORGANISATION AFRICAINE DE LA PROPRIÉTÉ INTELLECTUELLE (OAPI)/AFRICAN INTELLECTUAL PROPERTY ORGANIZATION (OAPI)

Hamidou KONE, chef du Service des Brevets et autres créations à caractère technique, Service des Brevets et autres créations à caractère technique, Département de la Protection de la Propriété Industrielle, Yaoundé

ORGANISATION EUROPÉENNE DES BREVETS (OEB)/EUROPEAN PATENT ORGANISATION (EPO)

Pierre HELD, Project Manager, CPC at National Offices and IP5 Working Group 1 Dir. 1.1.3., Classification and Documentation, Rijswijk

Roberto IASEVOLI, Head, Classification Knowledge Management, Rijswijk

III. BUREAU/OFFICERS

Président/Chair: Kunihiko FUSHIMI (Japon/Japan)

Vice-présidents/

Vice-Chairs: LU Huisheng (Chine/China)
Peter SLATER (Royaume-Uni/United Kingdom)

Secrétaire/Secretary: XU Ning (Mme/Mrs.) (OMPI/WIPO)

IV. BUREAU INTERNATIONAL DE L'ORGANISATION MONDIALE DE LA PROPRIÉTÉ
INTELLECTUELLE (OMPI)/INTERNATIONAL BUREAU OF THE WORLD
INTELLECTUAL PROPERTY ORGANIZATION

Yoshiyuki TAKAGI, sous-directeur général/Assistant Director General

Antonios FARASSOPOULOS, directeur de la Division des classifications internationales et des normes /Director, International Classifications and Standards Division

Patrick FIÉVET, chef de la Section des systèmes informatiques/Head, IT Systems Section

XU Ning (Mme/Mrs.), chef de la Section de la classification internationale des brevets (CIB)/
Head, International Patent Classification (IPC) Section

Rastislav MARČOK, administrateur principal de la classification des brevets de la Section de la classification internationale des brevets (CIB)/Senior Patent Classification Officer,
International Patent Classification (IPC) Section

Isabelle MALANGA SALAZAR (Mme/Mrs.), assistante à l'information de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de l'infrastructure mondiale/Information Assistant, International Patent Classification (IPC) Section, International Classifications and Standards Division, Global Infrastructure Sector

[L'annexe II suit/Annex II follows/
Sigue el Anexo II]